


<b>Search Notes</b>  	<b>Application/Control No.</b>  10550853	<b>Applicant(s)/Patent Under Reexamination</b>  MEUNIER-BEILLARD ET AL.
	<b>Examiner</b>  Nguyen, Khiem D	<b>Art Unit</b>  2823

SEARCHED			
Class	Subclass	Date	Examiner
438	222, 300, 478, 479, 481, 507	3/22/2007	K.N.
257	E21.106	3/22/2007	K.N.
438	222, 478, 479, 481, 507	4/1/2008	K.N.
118	715	4/1/2008	K.N.

SEARCH NOTES		
Search Notes	Date	Examiner
EAST text search (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB), see attached search history.	3/22/2007	K.N.
EAST text search (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB), see attached search history.	4/1/2008	K.N.
EAST text search (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB), see attached search history.	10/18/2008	/KN/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/KHIEM D NGUYEN/ Examiner.Art Unit 2823	
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